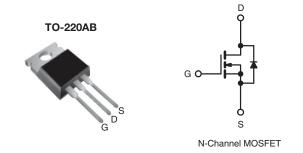


COMPLIANT

Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	20	200				
$R_{DS(on)}(\Omega)$	V _{GS} = 5.0 V	0.18				
Q _g (Max.) (nC)	66	66				
Q _{gs} (nC)	9.0	9.0				
Q _{gd} (nC)	38	38				
Configuration	Sing	Single				



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- $R_{DS(on)}$ Specified at $V_{GS} = 4 V$ and 5 V
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provides the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRL640PbF
	SiHL640-E3
SnPb	IRL640
	SiHL640

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise PARAMETER			SYMBOL	LIMIT	UNIT	
					Olviii	
Drain-Source Voltage			V _{DS}	200	V	
Gate-Source Voltage	•		V_{GS}	± 10		
Continuous Drain Current	V _{GS} at 5.0 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1_	17	A	
	VGS at 3.0 V	$T_C = 100 ^{\circ}C$	I _D	11		
Pulsed Drain Current ^a			I _{DM}	68		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	580	mJ	
Repetitive Avalanche Current ^a			I _{AR}	10	Α	
Repetitive Avalanche Energya			E _{AR}	13	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P _D	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		
Maunting Tayous	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque			<u> </u>	1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 3.0 mH, R_g = 25 Ω I_{AS} = 17 A (see fig. 12).
- c. $I_{SD} \leq 17$ A, $dI/dt \leq 150$ A/ μ s, $V_{DD} \leq V_{DS}$, $T_J \leq 1\bar{5}0$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST (MIN.	TYP.	MAX.	UNIT	
Static					•	•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = 1 mA	-	0.27	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	/ _{GS} , I _D = 250 μA	1.0	-	2.0	V
Gate-Source Leakage	I _{GSS}	V	V _{GS} = ± 10		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 2	V _{DS} = 200 V, V _{GS} = 0 V		-	25	μА
zero Gate voltage Drain Current		V _{DS} = 160 V, V	V _{DS} = 160 V, V _{GS} = 0 V, T _J = 125 °C		-	250	
Drain-Source On-State Resistance	В	V _{GS} = 5.0 V	I _D = 10 A ^b	-	-	0.18	Ω
Diani-Source On-State nesistance	R _{DS(on)}	V _{GS} = 4.0 V	$I_D = 8.5 A^b$	-	-	0.27	
Forward Transconductance	g fs	$V_{DS} = 5$	50 V, I _D = 10 A ^b	16	-	-	S
Dynamic							
Input Capacitance	C_{iss}	\	$V_{GS} = 0 \text{ V}$	1	1800	-	
Output Capacitance	C _{oss}	V	_{DS} = 25 V	1	400	-	pF
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		1	120	-	
Total Gate Charge	Q_g			-	-	66	nC
Gate-Source Charge	Q _{gs}	$V_{GS} = 5.0 \text{ V}$	$I_D = 17 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 ^b	-	-	9.0	
Gate-Drain Charge	Q_{gd}		see lig. 6 and 13	1		38	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 100 \text{ V}, I_{D} = 17 \text{ A}$ $R_{q} = 4.6 \Omega, R_{D} = 5.7 \Omega, \text{ see fig. } 10^{b}$		1	8.0	-	ns
Rise Time	t _r			-	83	-	
Turn-Off Delay Time	t _{d(off)}			-	44	-	
Fall Time	t _f	g			52	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		1	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	<u>.</u>					
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	17	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	68	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 17 A, V _{GS} = 0 V ^b		ı	-	2.0	٧
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C l -	17 A dl/dt = 100 A/usb	ı	310	470	ns
Body Diode Reverse Recovery Charge	Q_{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 17 \text{A}, dI/dt = 100 \text{A/µs}^{\text{b}}$		-	3.2	4.8	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	on is dominated by L _S and L _D)			L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

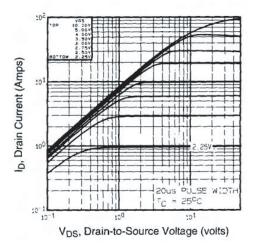


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

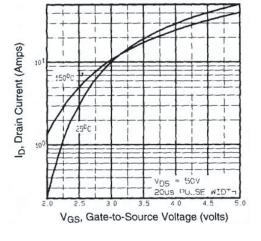


Fig. 3 - Typical Transfer Characteristics

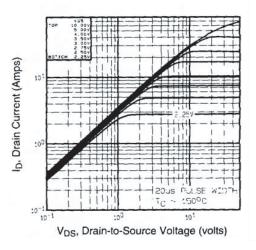


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

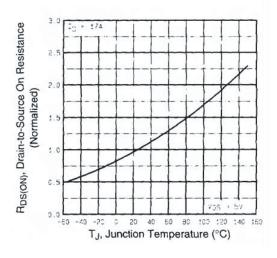


Fig. 4 - Normalized On-Resistance vs. Temperature



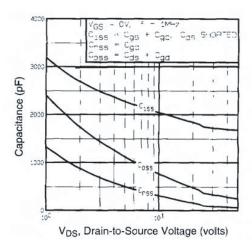


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

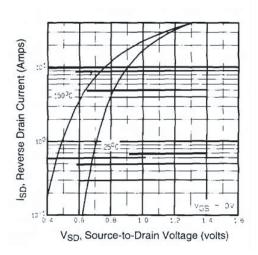


Fig. 7 - Typical Source-Drain Diode Forward Voltage

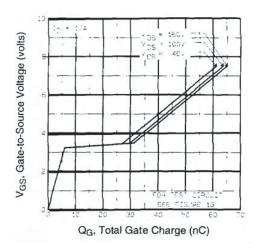


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

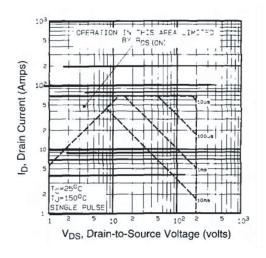


Fig. 8 - Maximum Safe Operating Area





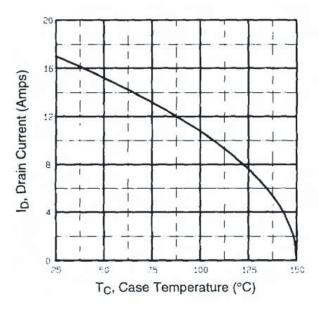


Fig. 9 - Maximum Drain Current vs. Case Temperature

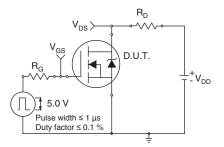


Fig. 10a - Switching Time Test Circuit

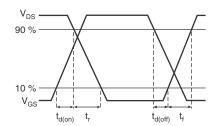


Fig. 10b - Switching Time Waveforms

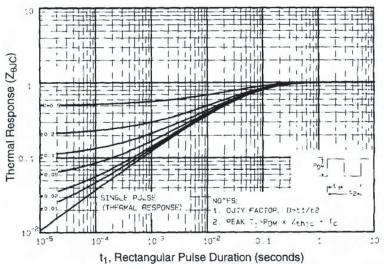


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



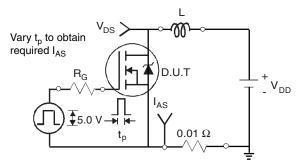


Fig. 12a - Unclamped Inductive Test Circuit

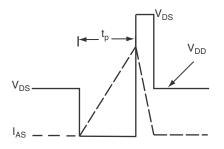


Fig. 12b - Unclamped Inductive Waveforms

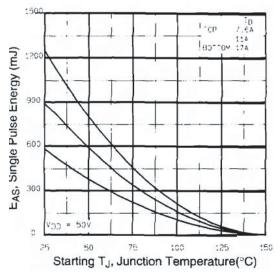


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

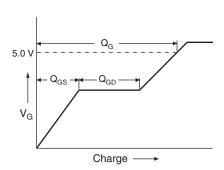


Fig. 13a - Basic Gate Charge Waveform

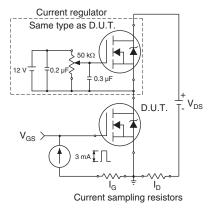
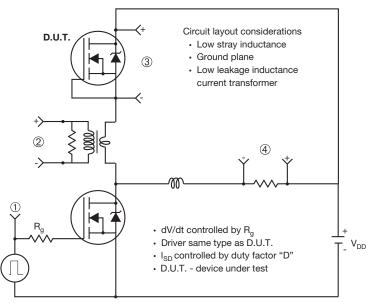


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



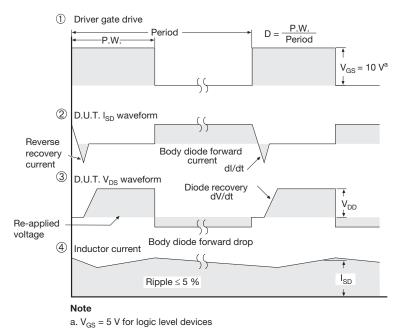
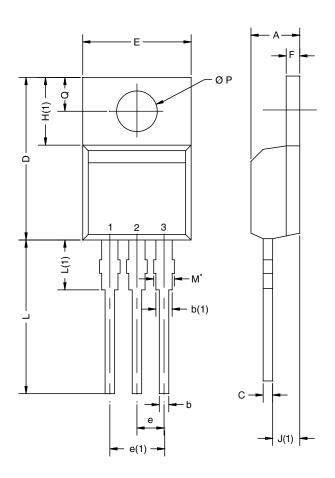


Fig. 14 - For N-Channel

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TO-220AB



	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØΡ	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: T13-0724-Rev. O, 14-Oct-13						

DWG: 5471

Note

 $^{^{\}star}$ M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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Revision: 02-Oct-12 Document Number: 91000